

Report No. MCR-22-0758 Date: Dec./1/2022

# RENESAS SEMICONDUCTOR RELIABILITY REPORT

- SERIES : RL78/F14
- DEVICE : R5F10PGxCyFB/R5F10PGxCyXXXFB (x=G/H/J,y=L/K)
- APPLICATION : Automobile

Quality Assurance Div. Renesas Electronics Corporation

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#### Notice

### Q100 Qualification Test Results for R5F10PGxCyFB/R5F10PGxCyXXXFB(x=G/H/J,y=L/K)

[Note : Basically qualification tests were performed using a representative product with the same wafer process and the same package structure .]

Test	#	Reference	Test Conditions	Lots	S.S.	Total	Results (Fail of Total)	Comments: (N/A =Not Applicable)
			TEST GROUP A – ACCELERAT	ED ENVIR	ONMENT S	STRESS TE	STS	
PC	A1	JESD22 A113 J-STD-020	Preconditioning: (Test @ Rm) SMD only; Moisture Preconditioning for THB/HAST, AC/UHST, TC, &PTC ; Peak Reflow Temp=260°C	Min.MSL=3		MSL=3	-	
THB <del>or</del> <del>HAST</del>	A2	JESD22 A101	Temperature Humidity Bias: (Test @ Rm/Hot) Ta=85°C, RH=85%, 1000hrs	3	77	231	0 of 231	-
<del>AC or</del> UHST <del>or TH</del>	A3	JESD22 A118	Unbiased Highly Accelerated Stree Test: (Test @ Rm) 110°C, 85% RH, 264h	3	77	231	0 of 231	-
тс	A4	JESD22 A104	Temperature Cycle: (Test @ Hot) Ta=-65°C to 150°C, 500cyc	3	77	231	0 of 231 0 Fails after TC (WBP)	-
PTC	A5	JESD22 A105	Power Temperature Cycle: (Test @ Rm/Hot)	-	-	-	-	N/A
HTSL	A6	JESD22 A103	High Temperature Storage Life: (Test @ Rm/Hot) Ta=150°C, 1000hrs	1	45	45	0 of 45	-

#### **TEST GROUP B – ACCELERATED LIFETIME SIMULATION TESTS**

HTOL	B1	JESD22 A108	High Temp Operating Life: (Test @ Rm/Cold/Hot) Ta=125°C, 1000hrs		3	77	231	0 of 231	-
ELFR	В2		Early Life Failure Rate: (Test @ Rm/Hot) Ta=125°C, 48hrs		3	800	2400	0 of 2400	-
EDR	B3	AEC-Q100-005	NVM Endurance & Data Retention Test:	For HTOL	3	77	231	0 of 231	-
LDR	15	AEC-Q100-005	(Test @ Rm/Hot)	For HTSL	1	45	45	0 of 45	-

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Test	#	Reference	Test Conditions	Lots	S.S.	Total	Results (Fail of Total)	Comments: (N/A =Not Applicable)			
	TEST GROUP C – PACKAGE ASSEMBLY INTEGRITY TESTS										
WBS	C1	AEC-Q100-001 AEC-Q003	Wire Bond Shear Test: (Cpk > 1.67)	30 bonds	5 parts Min.	30 bonds	0 of 30bonds	Cpk>1.67			
WBP	C2	Mil-STD-883 Method 2011 AEC-Q003	Wire Bond Pull: (Cpk > 1.67); Each bonder used	30 bonds	5 parts Min.	30 bonds	0 of 30bonds	Cpk>1.67			
SD	C3	JESD22 B102 JSTD-002D	Solderability: (>95% coverage) 8 hr steam aging prior to testing	1	15	15	0 of 15	-			
PD	C4	JESD22 B100, JESD22 B108 AEC-Q003	Physical Dimensions: (Cpk > 1.67)	3	10	30	0 of 30	Cpk>1.67			
SBS	C5	AEC-Q100-010 AEC-Q003	Solder Ball Shear: (Cpk > 1.67); 5 balls from min. of 10 devices	-	-	-	-	N/A			
LI	C6	JESD22 B105	Lead Integrity: (No lead cracking or breaking); Through-hole only; 10 leads from each of 5 devices	-	-	-	-	N/A			

#### **TEST GROUP D – DIE FABRICATION RELIABILITY TESTS**

EM	D1	JESD61	Electromigration:	-	-	-	Pass	Confirmed by process TEG
TDDB	D2	JESD35	Time Dependant Dielectric Breakdown:	-	-	-	Pass	Confirmed by process TEG
HCI	D3	JESD60 & 28	Hot Carrier Injection:	-	-	-	Pass	Confirmed by process TEG
NBTI	D4	JESD90	Negative Bias Temperature Instability:	-	-	-	Pass	Confirmed by process TEG
SM	D5	JESD61,87 & 202	Stress Migration:	-	-	-	Pass	Confirmed by process TEG

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Test	#	Reference	Test Conditions	Lots	S.S.	Total	Results (Fail of Total)	Comments: (N/A =Not Applicable)
1			TEST GROUP E- ELE	CTRICAL	VERIFICA	TION		
TEST	E1	User/Supplier Specification	Pre and Post Stress Electrical Test:	All	All	All	0 of All	-
НВМ	E2	AEC-Q100-002	Electrostatic Discharge, Human Body Model: (Test @ Rm/Hot); (2KV HBM / Class 2 or better)	1	3	3	0 of 3 ESD Level= HBM:2	HBM>2KV
CDM	E3	AEC-Q100-011	Electrostatic Discharge, Charged Device Model: (Test @ Rm/Hot); (750V corner leads, 500V all other leads / Class C4B or better)	1	3	3	0 of 3 ESD Level= CDM:C4B	Corner leads: 750V Pass All other leads:500V Pass
LU	E4	AEC-Q100-004	Latch-Up: (Test @ Rm/Hot)	1	6	6	0 of 6	-
ED	E5	AEC-Q100-009 AEC-Q003	Electrical Distributions: (Test @ Rm/Hot/Cold) (where applicable, Cpk>1.67)	3	30	90	Cpk>1.67	-
FG	E6	AEC-Q100-007	Fault Grading:	-	-	-	>98%	-
CHAR	E7	AEC-Q003	Characterization: (Test @ Rm/Hot/Cold)	-	-	-	Pass	According to Renesas standard procedure
EMC	E9	SAE J1752/3	Electromagnetic Compatibility (Radiated Emissions)	1	1	1	0 of 1	-
SC	E10	AEC Q100-012	Short Circuit Characterization	-	-	-	-	N/A
SER	E11	JESD89-1 JESD89-2 JESD89-3	Soft Error Rate	1	3	3	Pass	-
LF	E12	AEC-Q005	Lead (Pb) Free: (see AEC-Q005)	-	-	-	Pass	Solderability: See SD (C3) result. Solder heat resistance: N/A (Wave Solder is Not recommended.) Whisker: Performed on product TEG with test method based on JESD201.

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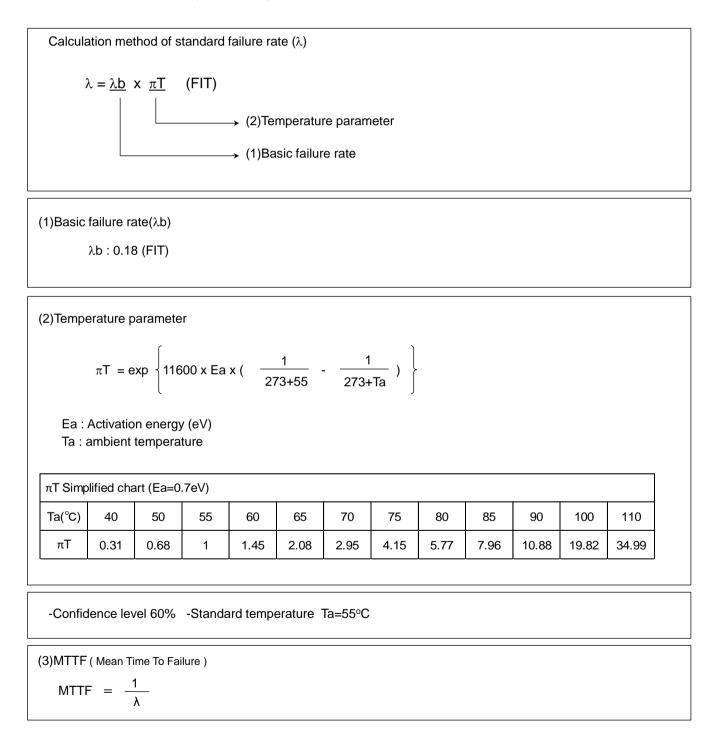
Test	#	Reference	Test Conditions	Lots	S.S.	Total	Results (Fail of Total)	Comments: (N/A =Not Applicable)		
. <u></u>			TEST GROUP F – DE	FECT SCR	EENING T	ESTS				
PAT	F1	AEC-Q001	Process Average Testing: (see AEC-Q001)	All	All	All	Reject units outside PAT limits	Apply to mass production according to Renesas standard procedure		
SBA	F2	AEC-Q002	Statistical Bin/Yield Analysis: (see AEC-Q002)	All	All	All	Reject units outside criteria	Apply to mass production according to Renesas standard procedure		
	TEST GROUP G – CAVITY PACKAGE INTEGRITY TESTS (for Ceramic Package testing only)									
MS	G1	JESD22 B104	Mechanical Shock: (Test @ Rm)	-	-	-	-	N/A		
VFV	G2	JESD22 B103	Variable Frequency Vibration: (Test @ Rm)	-	-	-	-	N/A		
CA	G3	MIL-STD-883 Method 2001	Constant Acceleration: (Test @ Rm)	-	-	-	-	N/A		
GFL	G4	MIL-STD-883 Method 1014	Gross and Fine Leak:	-	-	-	-	N/A		
DROP	G5		Drop Test: (Test @ Rm) MEMS cavity parts only. Drop part on each of 6 axes once from a height of 1.2m onto a concrete surface.	-	-	-	-	N/A		
LT	G6	MIL-STD-883 Method 2004	Lid Torque:	-	-	-	-	N/A		
DS	G7	MIL-STD-883 Method 2019	Die Shear:	-	-	-	-	N/A		
IWV	G8	MIL-STD-883 Method 1018	Internal Water Vapor:	-	-	-	-	N/A		



### Calculation method of standard failure rate

Target : 0.13um CMOS process product (RL78 series Automobile)

Operating reliability is decided by inherent reliability of device and environment condition of use (See below).



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	duct list						t No. MCR-22-0758
No	Group	Product part number	Package code	No	Group	Product part number	Package code
1	RL78/F14	R5F10PGGCKFB	PLQP0048KF-A	51	-		_
2	RL78/F14	R5F10PGGCKXXXFB	PLQP0048KF-A	52			_
3	RL78/F14	R5F10PGGCLFB	PLQP0048KF-A	53			_
4	RL78/F14	R5F10PGGCLXXXFB	PLQP0048KF-A	54	-		_
5	RL78/F14	R5F10PGHCKFB	PLQP0048KF-A	55			
6	RL78/F14	R5F10PGHCKXXXFB	PLQP0048KF-A	56			
7	RL78/F14	R5F10PGHCLFB	PLQP0048KF-A	57			_
8	RL78/F14	R5F10PGHCLXXXFB	PLQP0048KF-A	58	-		_
9	RL78/F14	R5F10PGJCKFB	PLQP0048KF-A	59			_
10	RL78/F14	R5F10PGJCKXXXFB	PLQP0048KF-A	60			_
11	RL78/F14	R5F10PGJCLFB	PLQP0048KF-A	61			
12	RL78/F14	R5F10PGJCLXXXFB	PLQP0048KF-A	62			
13				63			
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